LASER INTERFEROMETER GRAVITATIONAL WAVE OBSERVATORY

-LIGO-

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AdLIGO HEPI Pier Interface Chassis Test Procedure						
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LIGO-T0900346-v1

Performed by: Sam Abbott

Date: 10-12-09

Board Serial Number: 50900226

1. Overview

The HEPI Pier Interface Chassis serves several functions close to the vacuum envelope. One is to pass through and parse out the hydraulic valve actuation channels. A second function is to read out the L4C Seismometer channels, amplify them, and send them differentially to the Anti-Alias Chassis. Its last function is to read in the Inductive Position Sensor signals, whiten them, and send them differentially to the Anti-Alias Chassis.

The function of this procedure is to check each channel from its input to the respective output and to verify proper DC power consumption.

2. Test Equipment

- 2.1 Power Supply capable of +/- 18 volts
- 2.2 Function generator (Stanford Research DS360 or the like)
- 2.3 Oscilloscope
- 2.4 Stanford Research SR785 Network Analyzer, or the like

3. Preliminaries

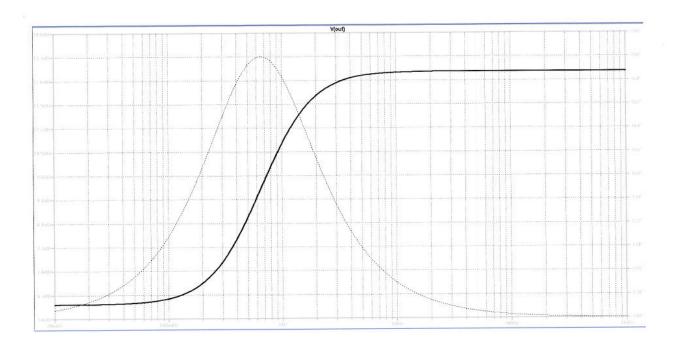
- 3.1 Perform visual inspection on board to check for missing components or solder deficiencies
- 3.2 Before connecting the power to the chassis, set power supplies to +/- 18 Volts, and then turn them off. Connect the power supplies to the chassis under test at the back panel 3-pin power connector labeled "Power In".

4. DC Tests

4.1 Turn on the power supplies to the system under test and record the total current.

Measure	Voltage	e read		Current
+18V Supply	TP4 (+15V +/- 0.5)	14.93	V	???mA +/- 10mA 100mA
-18V Supply	TP5 (-15V +/- 0.5)	-15.01	V	???mA +/- 10mA 100mA
Power LEDs	Equally bright?			N/A
IPS Power+	J10-1 / J10-3 (-15V +/- 0.5)	14.93	V	N/A
IPS Power-	J10-2 / J10-3 (-15V +/- 0.5)	-15.01	V	N/A

5.3 Inductive Position Sensor Channel Check: Set the SR785 for a 100mV source, and do a Swept Sine measurement from 10mHz to 10KHz on each channel. The nominal response is a Zero at 0.38Hz, and a pole at 0.86Hz. This should result in a gain change from 4 V/V at DC to 9 V/V at higher frequencies. The plot should look similar to the graph below.



INPUT IPS INPUT (DIFFERENTIAL)	OUTPUT TO AA CHASSIS (A) – (B)	VALUE LOOK LIKE THE GRAPH?	
IPS X In J10-4 / J10-5	To AA Chassis (J4-4/GND) – (J4-12/GND)	\checkmark	
IPSY In J10-6 / J1B-7	To AA Chassis (J4-5/GND) – (J4-13/GND)	*V	